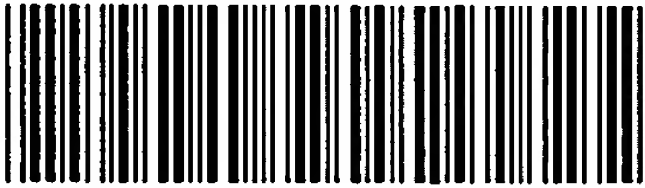


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/674,087	CHEN ET AL.	
	Examiner	Art Unit	
	Jon B. Ashen	1635	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST: including inventor search : please see attached and/or scanned notes and/or strategy	10/13/2005	JBA
STN: medline, biosis, embase, caplus: including inventor search : please see attached and/or scanned notes and/or strategy	10/12/2005	JBA